Application/Control No. Applicant(s)/Patent Under Reexamination 10/667,997 BERMAN ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 1746 Saeed T. Chaudhry **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY US-4,893,320 01-1990 Yanagi et al. 377/11 Α В US-6,138,698 10-2000 Tanaka et al. 134/184 С US-D US-Ε US-F US-G US-Н US-

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	JP11008214	01-1999	JAPAN	SAITO et al	
	0					
	Р					
	Q					
	R					
	s	•				
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

US-US-

US-US-

US-

J K

L M